

May 2014

FGD3245G2_F085 / FGB3245G2_F085

EcoSPARK®2 320mJ, 450V, N-Channel Ignition IGBT

Features

- SCIS Energy = 320mJ at T_J = 25°C
- Logic Level Gate Drive
- Low Saturation Voltage
- Qualified to AEC Q101
- RoHS Compliant

Applications

- Automotive Ignition Coil Driver Circuits
- Coil On Plug Applications

General Description

The FGB3245G2_F085 and FGD3245G2 are N-channel IGBTs designed in Fairchild's EcoSPARK-2 technology which helps in eliminating external protection circuitry. The technology is optimized for driving the coil in the harsh environment of automotive ignition systems and offers outstanding Vsat and SCIS Energy capability also at elevated operating temperatures. The logic level gate input is ESD protected and features an integrated gate resistor. An integrated zener-circuitry clamps the IGBT's collecter- to-emitter voltage at 450V which enables systems requiring a higher spark voltage

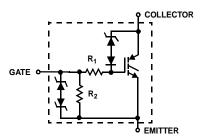


Package

Symbol







Device Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter	Rating	Units
BV _{CER}	Collector to Emitter Breakdown Voltage (I _C = 1mA)	450	V
BV _{ECS}	Emitter to Collector Voltage - Reverse Battery Condition (I _C = 10mA)	28	V
E _{SCIS25}	Self Clamping Inductive Switching Energy (Note 1)	320	mJ
	Self Clamping Inductive Switching Energy (Note 2)	180	mJ
I _{C25}	Collector Current Continuous, at V _{GE} = 4.0V, T _C = 25°C	23	Α
I _{C110}	Collector Current Continuous, at V _{GE} = 4.0V, T _C = 110°C	23	Α
V_{GEM}	Gate to Emitter Voltage Continuous	±10	V
D	Power Dissipation Total, at T _C = 25°C	150	W
P_D	Power Dissipation Derating, for T _C > 25°C	1.1	W/°C
T _J	Operating Junction Temperature Range	-40 to +175	°C
T _{STG}	Storage Junction Temperature Range	-40 to +175	°C
T _L	Max. Lead Temp. for Soldering (Leads at 1.6mm from case for 10s)		°C
T _{PKG}	Max. Lead Temp. for Soldering (Package Body for 10s)		°C
ESD	Electrostatic Discharge Voltage at100pF, 1500Ω	4	kV
ESD	CDM-Electrostatic Discharge Voltage at 1Ω	2	kV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FGD3245G2	FGD3245G2_F085	TO252AA	330mm	16mm	2500 units
FGB3245G2	FGB3245G2_F085	TO263AB	330mm	24mm	800 units

Electrical Characteristics $T_A = 25$ °C unless otherwise noted

Symbol Parameter	Test Conditions	Min	Тур	Max	Units
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Off State Characteristics

BV _{CER}	Collector to Emitter Breakdown Voltage	$I_{CE} = 2mA, V_{GE} = 0,$ $R_{GE} = 1K\Omega,$ $T_{J} = -40 \text{ to } 150^{\circ}\text{C}$		420	-	480	V
BV _{CES}	Collector to Emitter Breakdown Voltage	$I_{CE} = 10 \text{mA}, V_{GE} = 0 \text{V},$ $R_{GE} = 0,$ $T_{J} = -40 \text{ to } 150^{\circ}\text{C}$		440	1	500	٧
BV _{ECS}	Emitter to Collector Breakdown Voltage	I_{CE} = -75mA, V_{GE} = 0V, T_{J} = 25°C		28	-	-	V
BV _{GES}	Gate to Emitter Breakdown Voltage	I _{GES} = ±2mA		±12	±14	-	V
1	Collector to Emitter Leakage Current	V_{CE} = 250V, R_{GE} = 1K Ω	$T_J = 25^{\circ}C$	1	-	25	μΑ
ICER	Collector to Efficient Leakage Current		$T_{J} = 150^{\circ}C$	-	-	1	mA
	Emitter to Collector Leakage Current	V _{EC} = 24V,	$T_{J} = 25^{\circ}C$	-	-	1	mA
IECS	Emilier to Collector Leakage Current		$T_J = 150^{\circ}C$	-	-	40	IIIA
R ₁	Series Gate Resistance			-	120	-	Ω
R ₂	Gate to Emitter Resistance			10K	-	30K	Ω

On State Characteristics

V _{CE(SAT)}	Collector to Emitter Saturation Voltage	$I_{CE} = 6A, V_{GE} = 4V,$	$T_J = 25^{\circ}C$	-	1.13	1.25	V
V _{CE(SAT)}	Collector to Emitter Saturation Voltage	I_{CE} = 10A, V_{GE} = 4.5V,	$T_{\rm J} = 150^{\rm o}{\rm C}$	1	1.32	1.50	V
V _{CE(SAT)}	Collector to Emitter Saturation Voltage	$I_{CE} = 15A, V_{GE} = 4.5V,$	$T_{\rm J} = 150^{\rm o}{\rm C}$	-	1.64	1.85	V

Max Units

Min

Electrical Characteristics T_A = 25°C unless otherwise noted

Parameter

Dynamic Characteristics							
Q _{G(ON)}	Gate Charge	I _{CE} = 10A, V _{CE} = 12V, V _{GE} = 5V		-	23	-	nC
V _{GE(TH)}	Gate to Emitter Threshold Voltage	I _{CE} = 1mA, V _{CE} = V _{GE}	$T_{J} = 25^{\circ}C$	1.3	1.6	2.2	V
GE(TH)	Cate to Elimiter Threshold Voltage	I'CE IIIV, VCE VGE,	$T_{\rm J} = 150^{\rm o}{\rm C}$	0.75	1.1	1.8	
V_{GEP}	Gate to Emitter Plateau Voltage	V _{CE} = 12V, I _{CE} = 10A		-	2.7	-	V

Test Conditions

Switching Characteristics

t _{d(ON)R}	Current Turn-On Delay Time-Resistive	0		•	0.9	4	μS
t _{rR}	Current Rise Time-Resistive	$V_{GE} = 5V, R_{G} = 1K\Omega$ $T_{J} = 25^{\circ}C,$		1	2.6	7	μS
t _{d(OFF)L}	,	V _{CE} = 300V, L = 1mH,		1	5.4	15	μS
t _{fL}		$V_{GE} = 5V, R_G = 1K\Omega$ $I_{CE} = 6.5A, T_J = 25^{\circ}C,$		ı	2.7	15	μS
E _{SCIS}	I Self Clamped Inductive Switching	L = 3.0 mHy,RG = 1K Ω , VGE = 5V, (Note 1)	TJ = 25°C	-	-	320	mJ

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance Junction to Case	All packages	-	-	0.9	°C/W

Notes:

Symbol

- 1: Self Clamping Inductive Switching Energy (E_{SCIS25}) of 320 mJ is based on the test conditions that starting Tj=25°C; L=3mHy, I_{SCIS} =14.6A, V_{CC} =100V during inductor charging and V_{CC} =0V during the time in clamp.
- 2: Self Clamping Inductive Switching Energy ($E_{SCIS150}$) of 180 mJ is based on the test conditions that starting Tj=150°C; L=3mHy, I_{SCIS} =10.9A, V_{CC} =100V during inductor charging and V_{CC} =0V during the time in clamp.

Typical Performance Curves

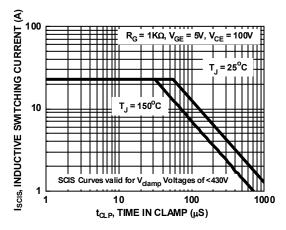


Figure 1. Self Clamped Inductive Switching Current vs. Time in Clamp

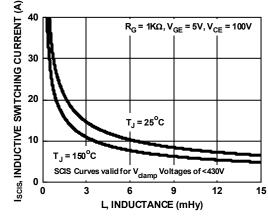


Figure 2. Self Clamped Inductive Switching Current vs. Inductance

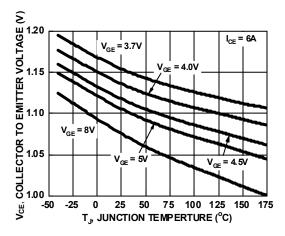


Figure 3. Collector to Emitter On-State Voltage vs. Junction Temperature

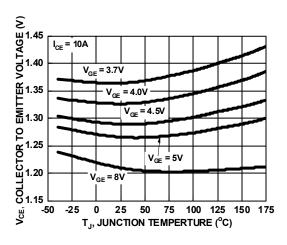


Figure 4. Collector to Emitter On-State Voltage vs. Junction Temperature

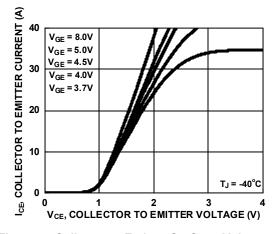


Figure 5. Collector to Emitter On-State Voltage vs. Collector Current

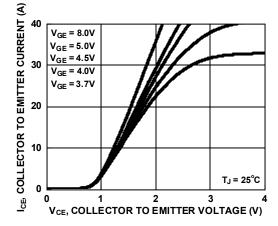


Figure 6. Collector to Emitter On-State Voltage vs. Collector Current

Typical Performance Curves (Continued)

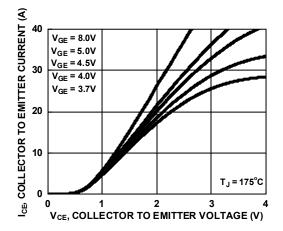


Figure 7. Collector to Emitter On-State Voltage vs. Collector Current

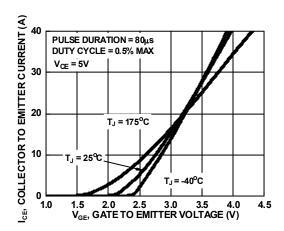


Figure 8. Transfer Characteristics

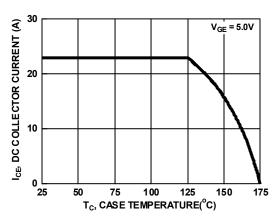


Figure 9. DC Collector Current vs. Case Temperature

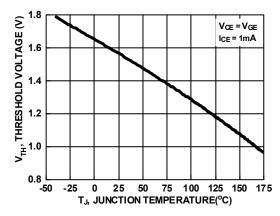


Figure 10. Threshold Voltage vs. Junction Temperature

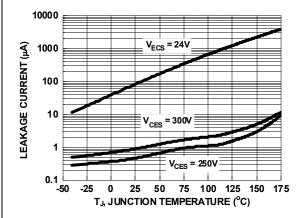


Figure 11. Leakage Current vs. Junction Temperature

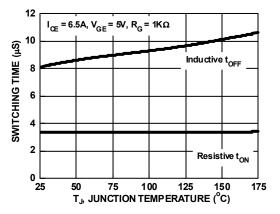
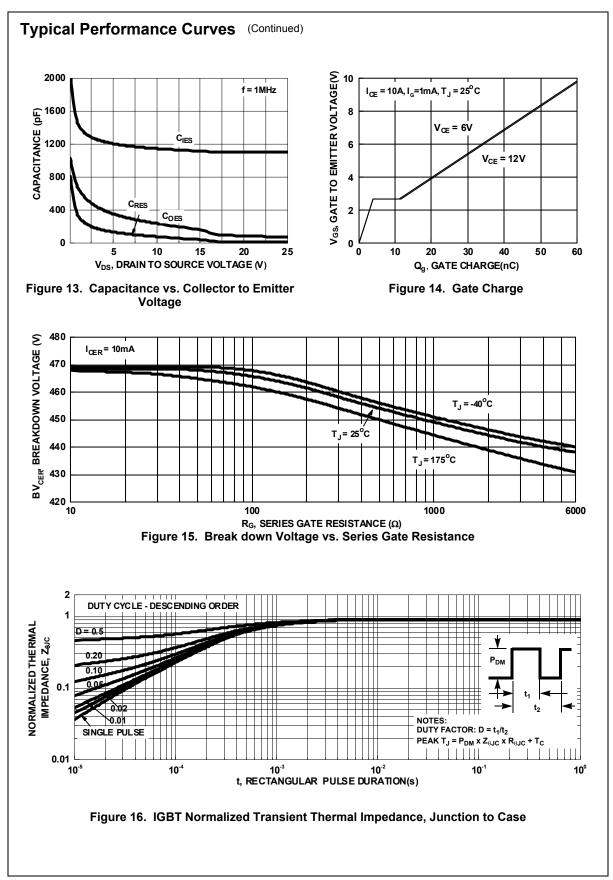
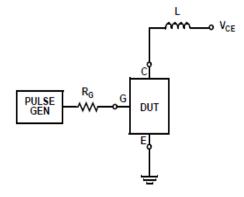


Figure 12. Switching Time vs. Junction Temperature

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Test Circuit and Waveforms



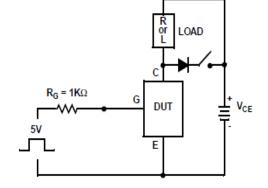


Figure 17. Inductive Switching Test Circuit

Figure 18. t_{ON} and t_{OFF} Switching Test Circuit

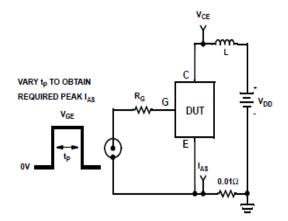


Figure 19. Energy Test Circuit

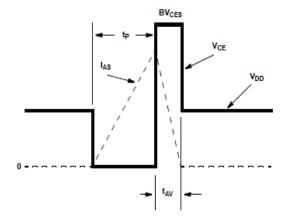


Figure 20. Energy Waveforms





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